

Notice of References Cited	Application/Control No. 10/509,969	Applicant(s)/Patent Under Reexamination HAUKE ET AL.	
	Examiner BRIAN YENKE	Art Unit 2422	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0009771	01-2003	Chang, Glen C.	725/135
*	B	US-6,983,464	01-2006	Bhattacharya et al.	719/318
*	C	US-7,507,119	03-2009	Ni et al.	439/607.31
*	D	US-2002/0186329	12-2002	Tong et al.	348/839
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.